

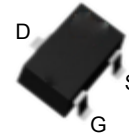
Features

- 20V/6A
 - $R_{DS(ON)}=10\text{m}\Omega(\text{max.})@V_{GS}=4.5\text{V}$
 - $R_{DS(ON)}=13\text{m}\Omega(\text{max.})@V_{GS}=2.5\text{V}$
- 100% UIS + R_g Tested
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)
- Moisture Sensitivity Level MSL1 (per JEDEC J-STD-020D)

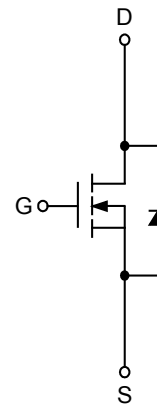
Applications

- Power Management in Notebook Computer, Portable Equipment and Battery Powered Systems.

Pin Description



Top View of SOT-23-3



N-Channel MOSFET

Absolute Maximum Ratings ($T_A=25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Rating	Unit
Common Ratings			
V_{DSS}	Drain-Source Voltage	20	V
V_{GSS}	Gate-Source Voltage	± 12	
T_J	Maximum Junction Temperature	150	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to 150	
I_S	Diode Continuous Forward Current	$T_A=25^\circ\text{C}$ 6	A
I_D	Continuous Drain Current	$T_A=25^\circ\text{C}$ 6	A
		$T_A=70^\circ\text{C}$ 2.4	
I_{DM}	Pulsed Drain Current	$T_A=25^\circ\text{C}$ 18	
P_D	Maximum Power Dissipation	$T_A=25^\circ\text{C}$ 1	W
		$T_A=70^\circ\text{C}$ 0.7	
$R_{\theta JA}^b$	Thermal Resistance-Junction to Ambient	$t \leq 10\text{s}$ 80	$^\circ\text{C/W}$
		Steady state 120	
I_{AS}^c	Avalanche Current, Single pulse	$L=0.1\text{mH}$ 15	A
E_{AS}^c	Avalanche Energy, Single pulse	$L=0.1\text{mH}$ 11.3	mJ

Note a : Max. continuous current is limited by bonding wire.

Note b : Surface mounted on 1in^2 pad area, steady state $t = 999\text{s}$.

Note c : UIS tested and pulse width limited by maximum junction temperature 150°C (initial temperature $T_J=25^\circ\text{C}$).

Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

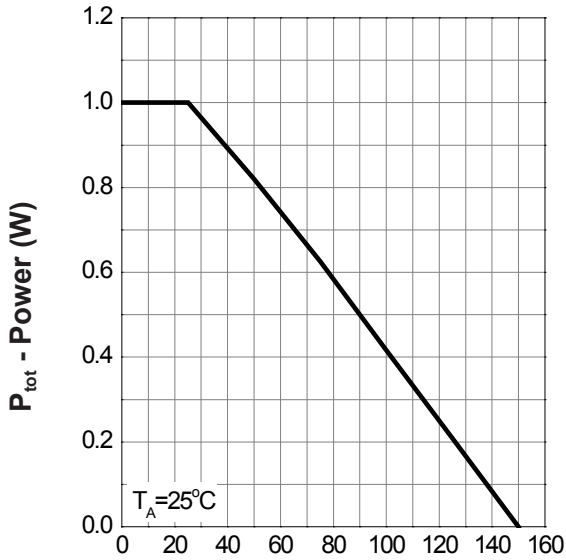
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_{DS}=250\mu A$	20	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=16V, V_{GS}=0V$ $T_J=85^\circ\text{C}$	-	-	1	μA
			-	-	30	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=250\mu A$	0.45	0.7	1	V
I_{GSS}	Gate Leakage Current	$V_{GS}=\pm 12V, V_{DS}=0V$	-	-	± 100	nA
$R_{DS(ON)}^d$	Drain-Source On-state Resistance	$V_{GS}=4.5V, I_{DS}=6A$ $T_J=125^\circ\text{C}$	-	10	13	m Ω
			-	13.6	-	
		$V_{GS}=2.5V, I_{DS}=5A$	-	13	18	
Gfs	Forward Transconductance	$V_{DS}=5V, I_{DS}=6A$	-	13.5	-	S
Diode Characteristics						
V_{SD}^d	Diode Forward Voltage	$I_{SD}=3A, V_{GS}=0V$	-	0.7	1.1	V
t_{rr}	Reverse Recovery Time	$I_{SD}=6A, dI_{SD}/dt=100A/\mu s$	-	11.7	-	ns
t_a	Charge Time		-	6	-	
t_b	Discharge Time		-	5.7	-	
Q_{rr}	Reverse Recovery Charge		-	4	-	
Dynamic Characteristics^e						
R_G	Gate Resistance	$V_{GS}=0V, V_{DS}=0V, F=1\text{MHz}$	-	1.4	-	Ω
C_{iss}	Input Capacitance	$V_{GS}=0V,$ $V_{DS}=10V,$ Frequency=1.0MHz	-	772	1004	pF
C_{oss}	Output Capacitance		-	167	-	
C_{riss}	Reverse Transfer Capacitance		-	105	-	
$t_{d(ON)}$	Turn-on Delay Time	$V_{DD}=10V, R_L=10\Omega,$ $I_{DS}=1A, V_{GEN}=4.5V,$ $R_G=6\Omega$	-	6	11	ns
t_r	Turn-on Rise Time		-	13	24	
$t_{d(OFF)}$	Turn-off Delay Time		-	26	48	
t_f	Turn-off Fall Time		-	5	10	
Gate Charge Characteristics^e						
Q_g	Total Gate Charge	$V_{DS}=10V, V_{GS}=4.5V,$ $I_{DS}=6A$	-	8.9	11.6	nC
Q_{gth}	Threshold Gate Charge		-	0.3	-	
Q_{gs}	Gate-Source Charge		-	0.6	-	
Q_{gd}	Gate-Drain Charge		-	3.5	-	

Note d : Pulse test ; pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.

Note e : Guaranteed by design, not subject to production testing.nd on package type.

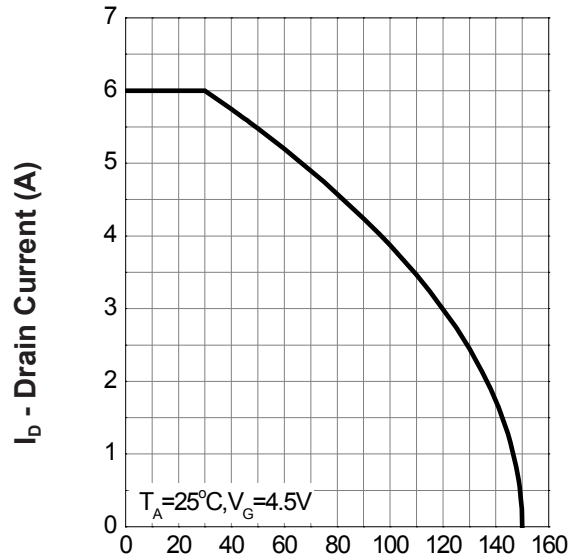
Typical Operating Characteristics

Power Dissipation



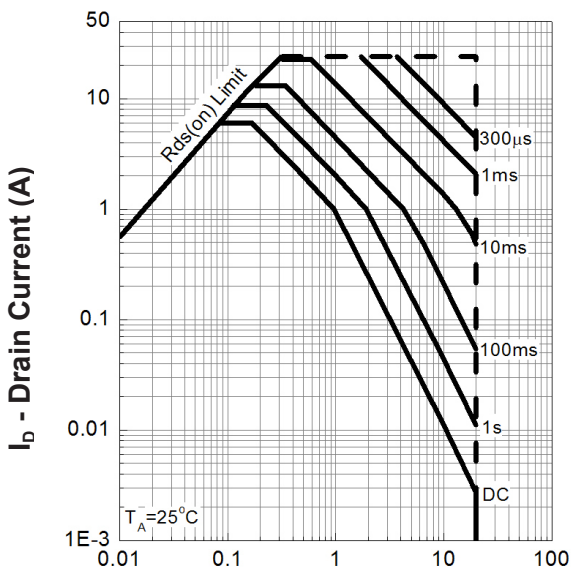
T_j - Junction Temperature ($^\circ\text{C}$)

Drain Current



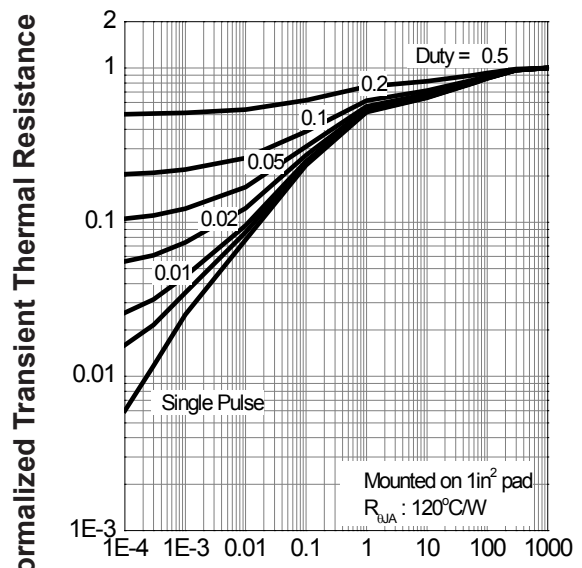
T_j - Junction Temperature ($^\circ\text{C}$)

Safe Operation Area



V_{DS} - Drain - Source Voltage (V)

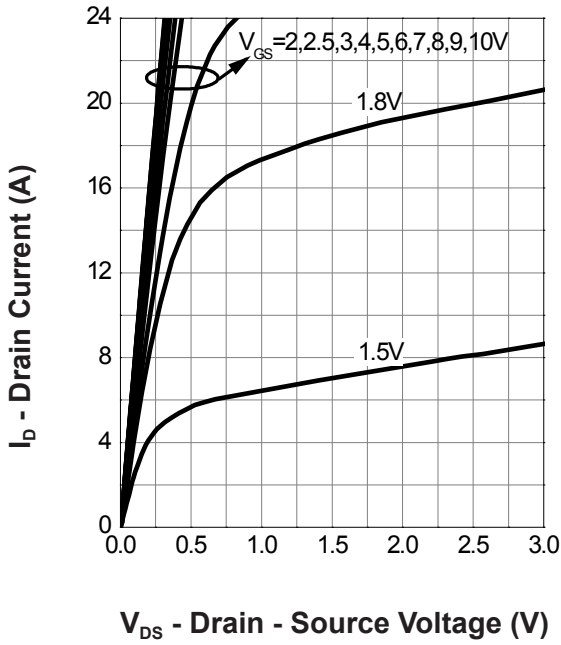
Thermal Transient Impedance



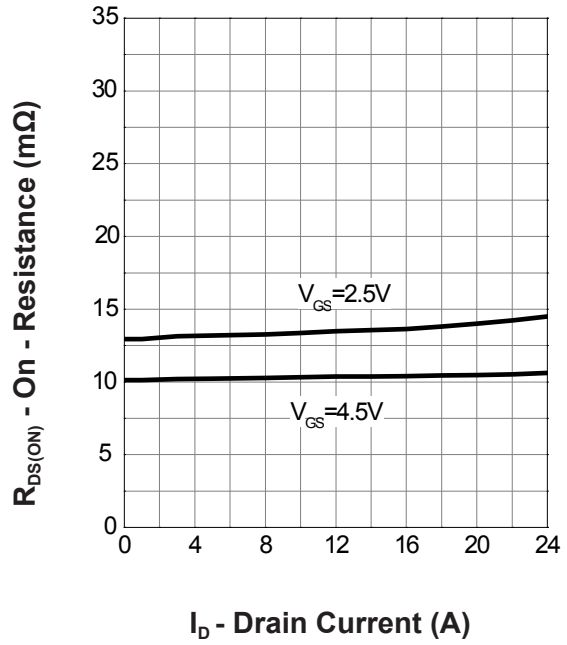
Square Wave Pulse Duration (sec)

Typical Operating Characteristics(Cont.)

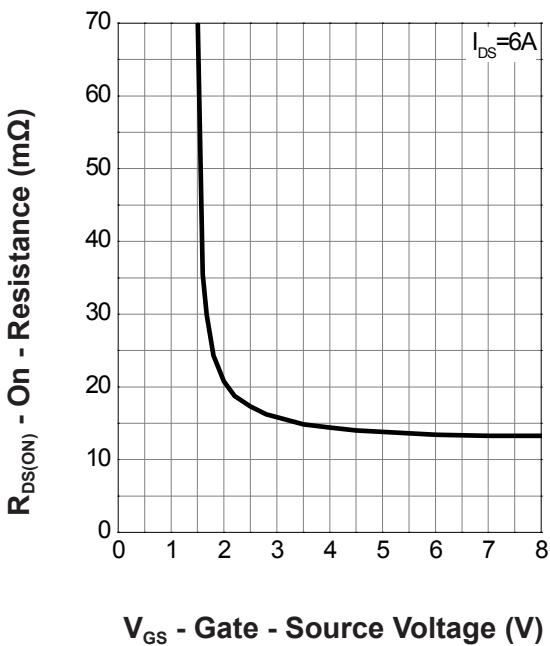
Output Characteristics



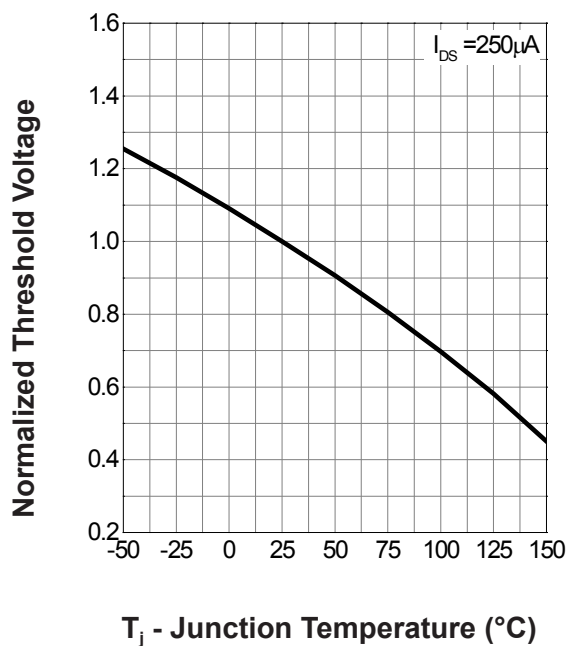
Drain-Source On Resistance



Gate-Source On Resistance

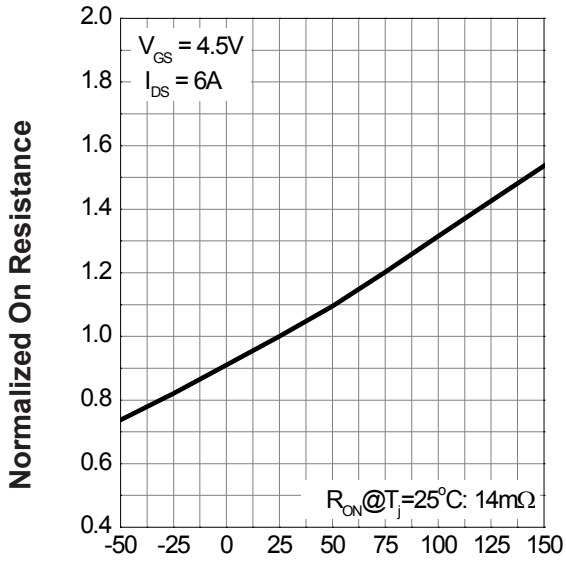


Gate Threshold Voltage



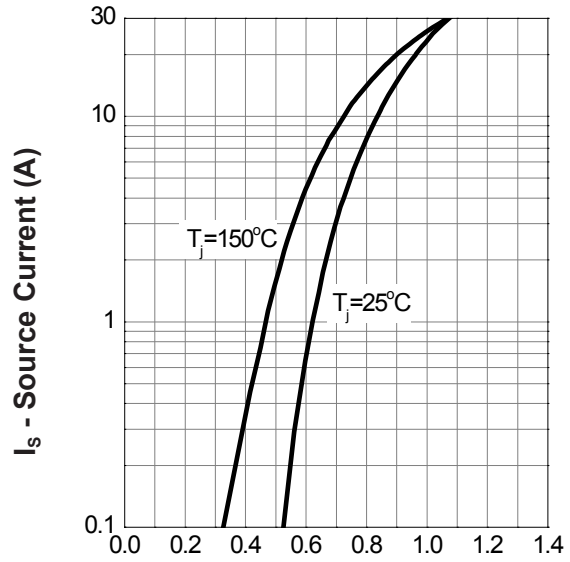
Typical Operating Characteristics(Cont.)

Drain-Source On Resistance



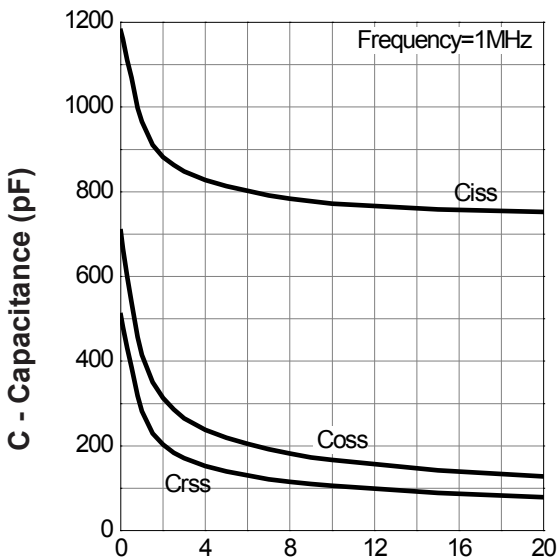
T_j - Junction Temperature (°C)

Source-Drain Diode Forward



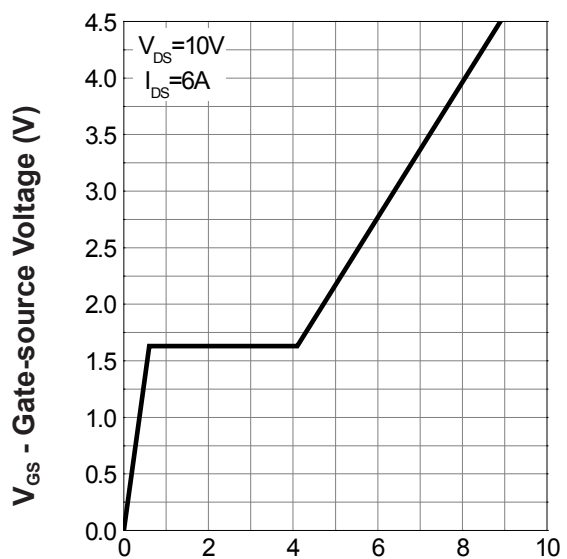
V_{SD} - Source - Drain Voltage (V)

Capacitance



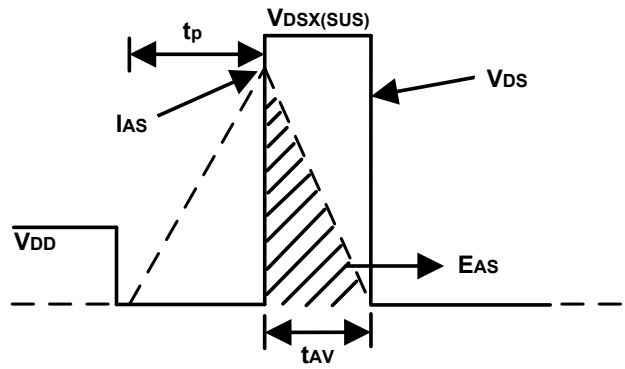
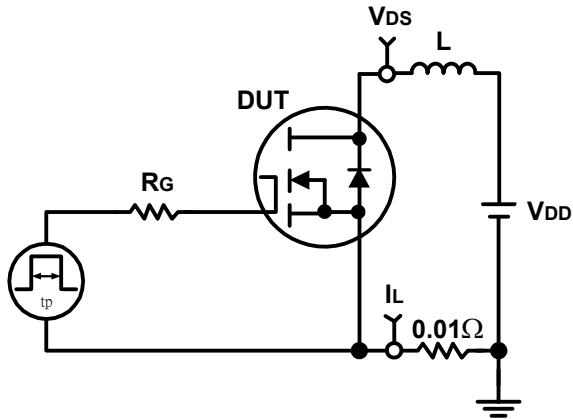
V_{DS} - Drain-Source Voltage (V)

Gate Charge

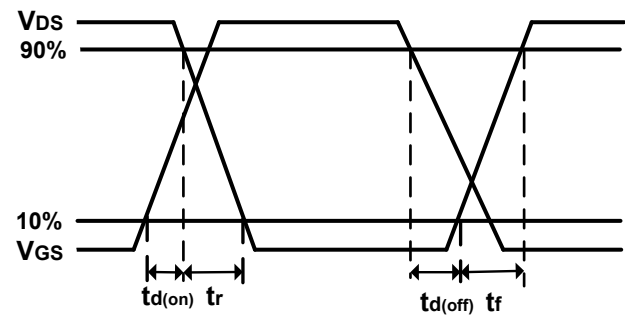
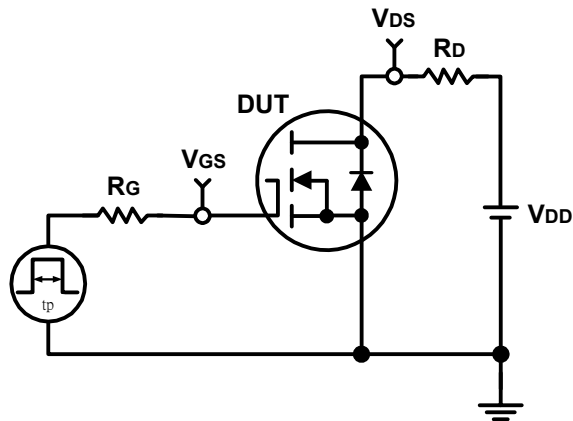


Q_G - Gate Charge (nC)

Avalanche Test Circuit and Waveforms

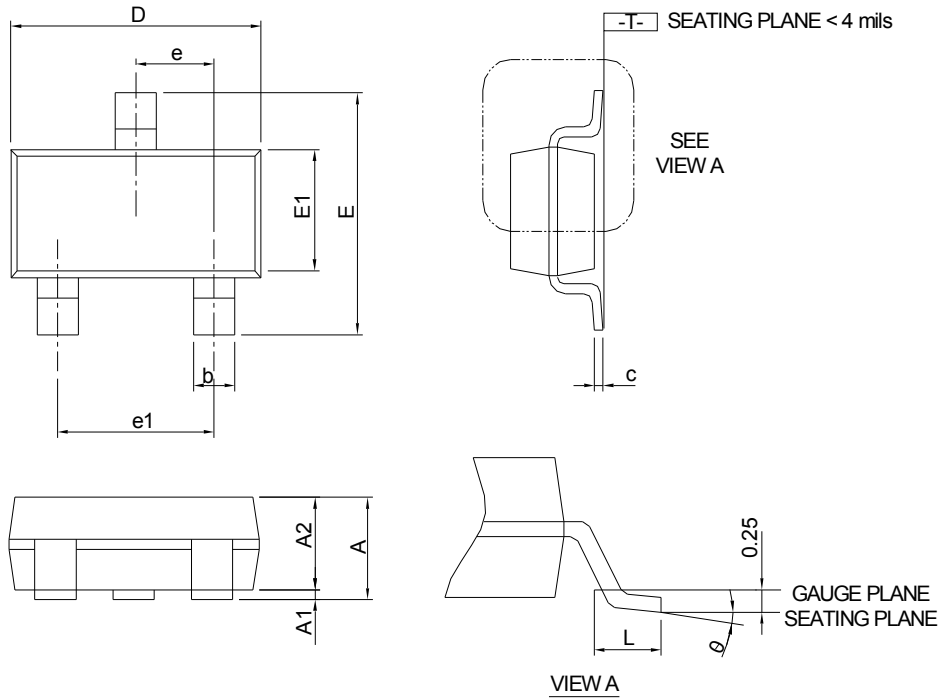


Switching Time Test Circuit and Waveforms



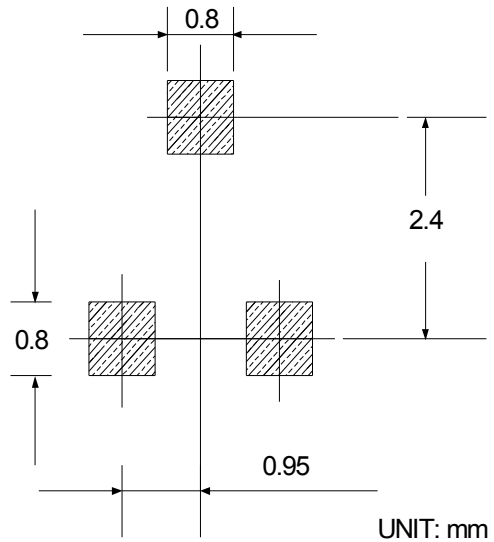
Package Information

SOT-23-3



SYMBOL	SOT-23-3			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	-	1.20	-	0.047
A1	0.00	0.08	0.000	0.003
A2	0.90	1.12	0.035	0.044
b	0.30	0.50	0.012	0.020
c	0.08	0.22	0.003	0.009
D	2.70	3.10	0.106	0.122
E	2.60	3.00	0.102	0.118
E1	1.40	1.80	0.055	0.071
e	0.95 BSC		0.037 BSC	
e1	1.90 BSC		0.075 BSC	
L	0.30	0.60	0.012	0.024
theta	0°	8°	0°	8°

RECOMMENDED LAND PATTERN



Note : Dimension D and E1 do not include mold flash, protrusions or gate burrs. Mold flash, protrusion or gate burrs shall not exceed 10 mil per side.